



**Kirk Pruhs**



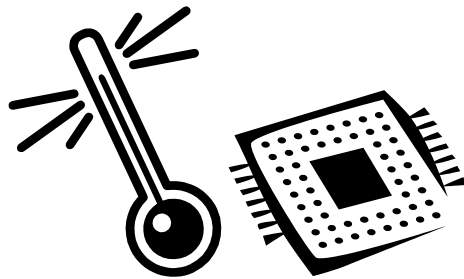
**Green Computing  
Algorithmics**

**Talk 1:  
Energy Efficient  
Circuit Design**

**ADFOCS 2015**

# Motivation: Moore's Gap

- Moore's Law: Transistor density doubles every 18-24 months.
- Computer performance has not kept pace over the last 10 years due to the prohibitive cost of cooling such a high density of switches. The result is "Moore's Gap".



Moore's Law ran smoothly until 2002, when the gap between performance and gate count started to appear.

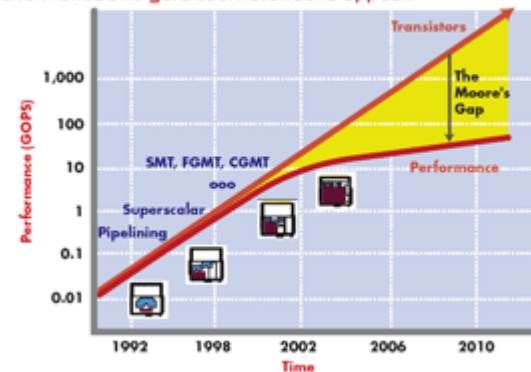




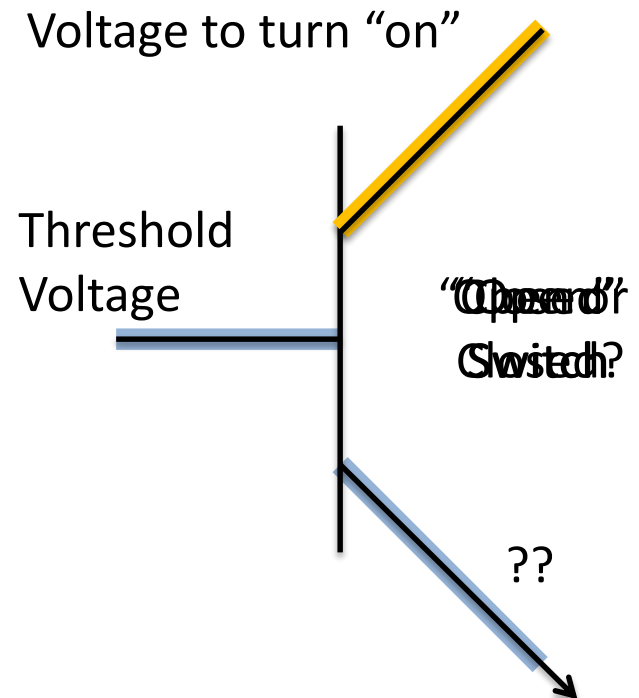
Figure 2

- One possible partial solution: Near Threshold Computing

# Transistors 101

- The building blocks of computers
- Acts as a switch when supplied with a high voltage
- **Threshold Voltage:** The lowest voltage at which the switch works (ideally)
- In reality, the probability that the switch works depends on the difference between the supply and threshold voltages.

High Voltage:   
Low Voltage: 



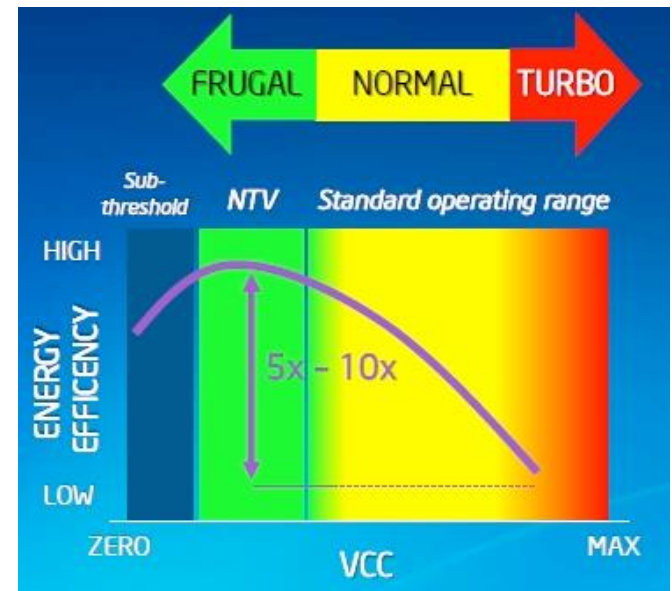
# Traditional Approach to Setting the Supply Voltage

- Increase supply voltage so, by the union bound over all transistors, no transistor fails.
- Benefits:
  - Reliability
  - Also speed

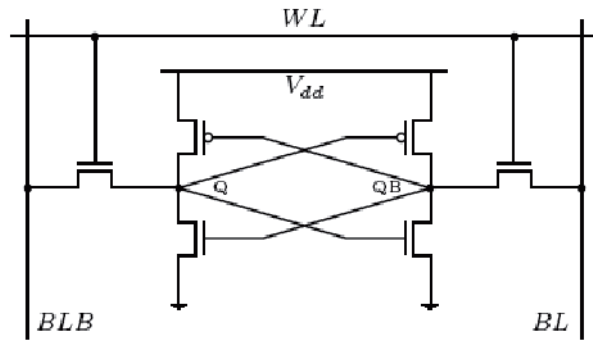


# Near-Threshold Computing

- Set the supply voltage close to the threshold voltage
- Advantage: Save energy per transistor
- Disadvantage: Decrease reliability per transistor. Requires fault-tolerant circuits.

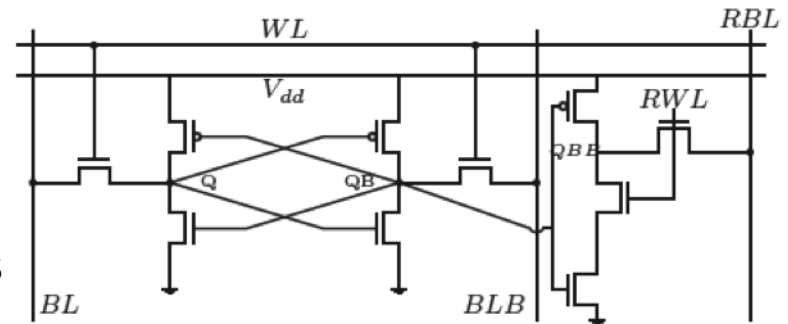


# Minimizing Energy is a Balancing Act



(a) Standard 6-transistor design.

SRAM circuits



(b) A more fault-tolerant 10-transistor design from [3].

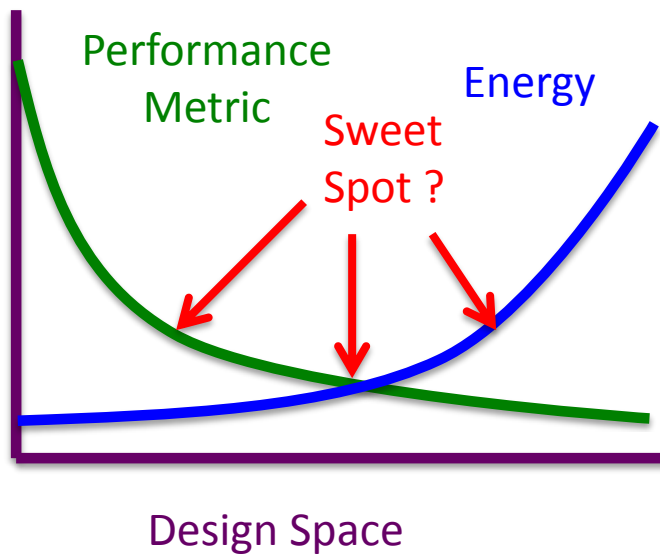
- Traditional:
  - Smaller number of transistors
    - nonfault tolerant circuit
  - Higher energy per transistor

**vs.**



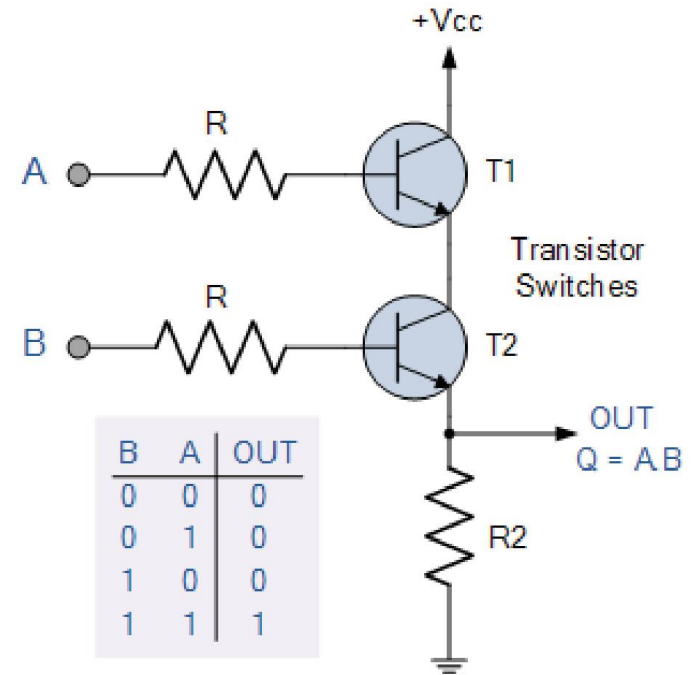
- Near-threshold:
  - Larger number of transistors in a fault tolerant
  - Lower energy per transistor

# Current State Of Theory of Energy as a Computational Resource: Energy vs. Performance Tradeoffs



# From Transistors to Gates

- Gates are composed of resistors and transistors, e.g.,
  - High Voltage: 1
  - Low Voltage: 0
- For simplicity, consider gates rather than transistors



Two transistor AND gate



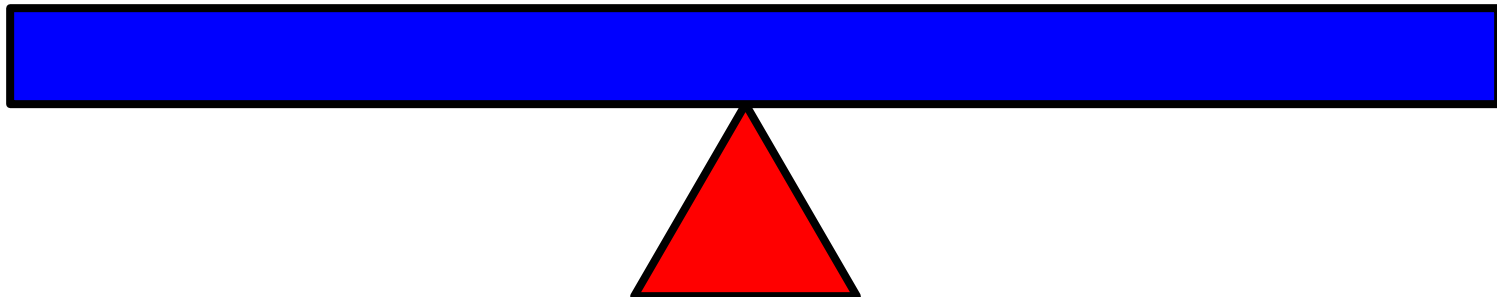
- If you wanted to do algorithmic research on near-threshold computing, what would you have to do first?

# Algorithmists' View of Science/Theory

- Science research tries to **model** a complex system by something simple, accurate, amenable to math and predictive. **Muthu Muthukrishnan's blog**

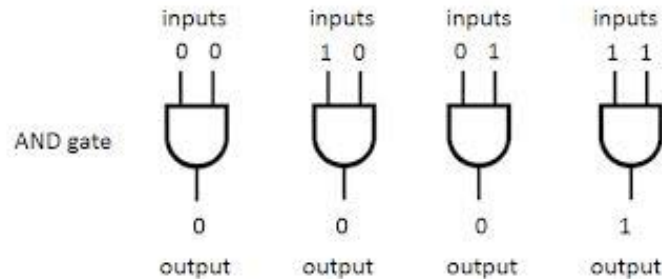
- Accuracy
- Realism
- Predictive

- Simplicity
- Amenable to math



# Two Modeling Issues

- Relationship between energy and error at a gate
- What happens when there is a error



# Voltage, Energy, and Error

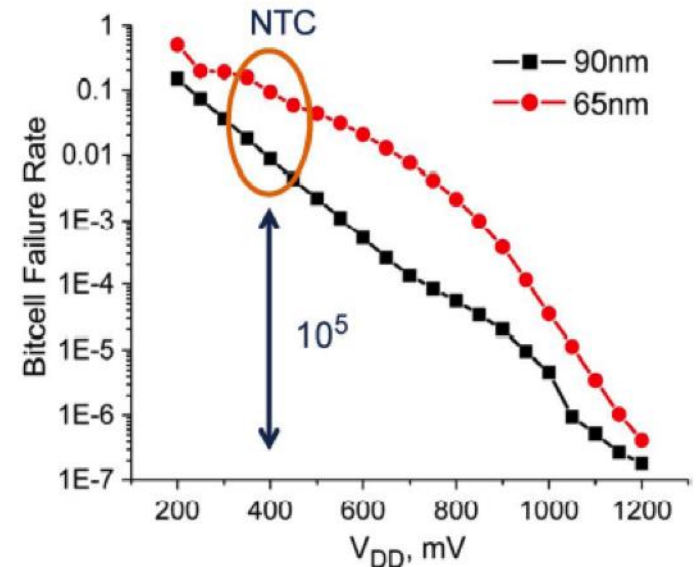


- Let  $v$  be the supply voltage
- $\text{Power}/\text{Energy} = v^2$
- Error Probability  $\epsilon = 2^{-v}$
- There, error to energy function  $E(\epsilon) = \log^2 1/\epsilon$ 
  - Not crucial

## Near-Threshold Computing: Reclaiming Moore's Law Through Energy Efficient Integrated Circuits

*Future computer systems promise to achieve an energy reduction of 100 or more times with memory design, device structure, device fabrication techniques, and clocking, all optimized for low-voltage operation.*

By RONALD G. DRESLINSKI, MICHAEL WIECKOWSKI, DAVID BLAAUW, Senior Member IEEE, DENNIS SYLVESTER, Senior Member IEEE, AND TREVOR MUDGE, Fellow IEEE

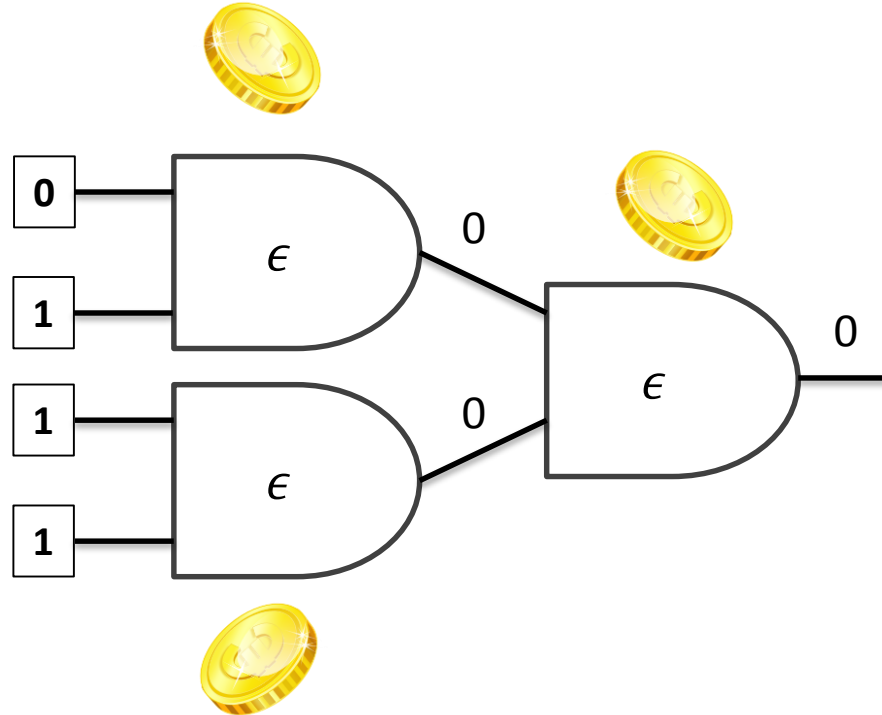


# Modeling Errors

- Error type models:
  - Toggle
  - Stuck-at
  - Generally not crucial
- Probability models
  - Exact: probability of error is exactly  $\varepsilon$
  - Bounded: probability of error is adversarially set to be in the range  $[0, \varepsilon]$
  - Generally not crucial

# Example – 3 AND Gates

Each gate fails/toggles independently with probability  $\epsilon$

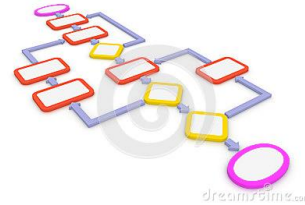


- Now what are some interesting research questions?

# Natural Problem: Finding Minimum Energy Circuit (MEC)

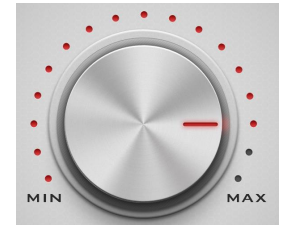
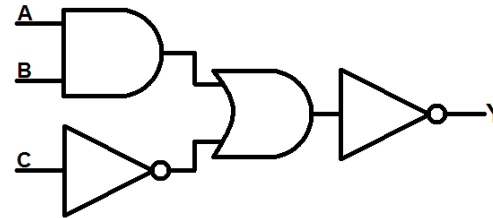
- Input:

- A function/relation  $F$
- Desired error bound  $\delta$



- Output:

- Circuit  $C$  that computes  $F$
- Setting of the supply voltage



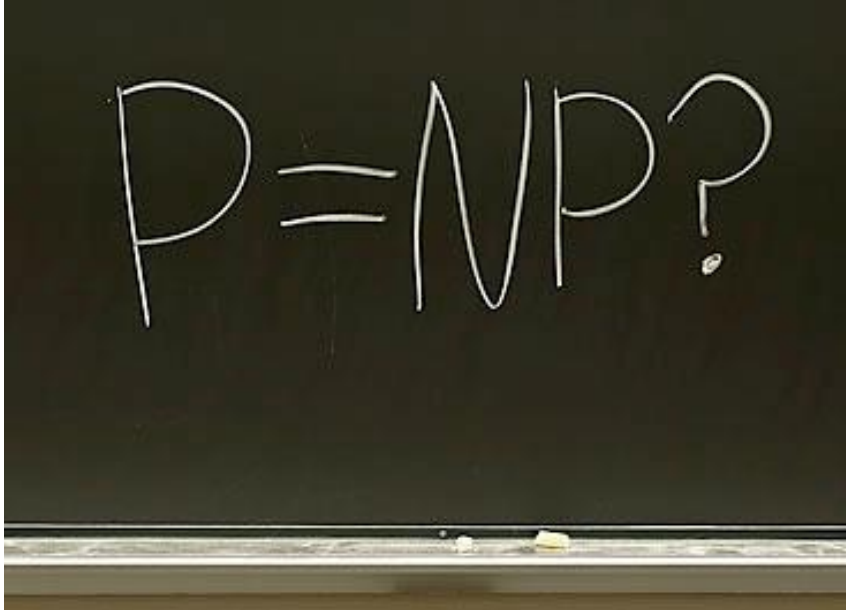
- Constraint: On all inputs the circuit should be correct with probability  $> 1-\delta$
- Objective: Minimize power





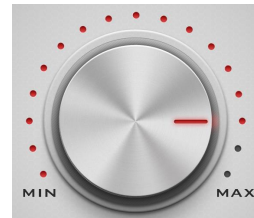
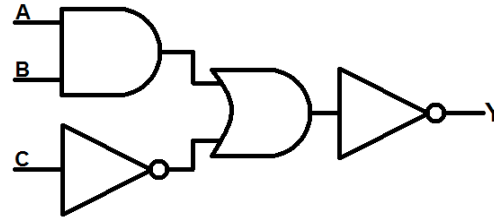
# Unfortunately...

- This problem is too hard. We don't have a clue how to find small circuits. **As hard as P vs. NP.**



# Natural Fallback Problem: Deciding the Right Supply Voltage for a Circuit (MCE)

- Input:
  - Combinatorial circuit
  - Desired error bound  $\delta$
- Output:
  - Setting of the supply voltage

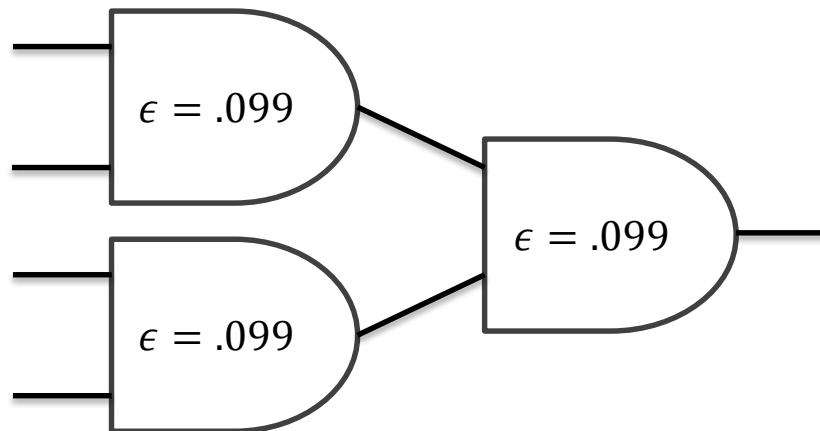


- Constraint: On all inputs the circuit should be correct with probability  $> 1-\delta$
- Objective: Minimize power



# MCE Problem

**Input:** Following circuit and  $\delta = .75$



- **Output:**
  - $\epsilon \approx .099$
  - Energy =  $3 \log^2 (1/.099) \approx 33.39$

# Obvious Natural Questions

- MEC
  - General lower bounds on energy?
  - General upper bounds on energy?
  - Energy for a random function?
- MCE
  - Complexity?
  - Approximation ratio of traditional approach?
  - Best possible approximation ratio?

# Less Obvious Natural Questions

- Can you save energy by making supply voltages heterogeneous?
  - Does it matter whether you computing a function or an injective relation (so you don't care on some inputs)?
  - Does it matter the circuit error bound  $\delta$  is a constant or if  $\delta$  goes to 0 as the circuit size increases?

# Roadmap

- General bounds
- Approximation for Minimum Circuit Energy (MCE)
- Minimum Energy Circuit (MEC) for random functions
- Energy savings from allowing heterogeneous supply voltages

# Previous Work: Fault Tolerant Circuits

- Introduced by **von Neumann** in **1956**: **fixed probability of error  $\epsilon$**
- Upper bound of  $O(N \log N)$  given a faultless circuit of size  $N$ .
  - Heuristically argued by **von Neumann**, formalized and made more explicit by **Dobrushin and Ortyukov (77)**, **Pippenger (85)**, and **Gács (05)**.
- Lower bound of  $\Omega(s \log s)$  for functions with sensitivity  $s$ .
  - **Dobrushin and Ortyukov (77)** published proof containing errors, correctly proved by **Gács and Gál (94)**.

# Warmup

- Recall  $\delta$  is given circuit error
  - Recall  $\epsilon$  is gate error that needs to be determined
  - Recall  $s$  = number of gates
  - Energy  $E(\epsilon) = \log^2 1/\epsilon$
- 
- Lemma:  $\delta/s \leq \epsilon \leq \delta$
  - Proof?
- 
- Corollary: Energy per gate is  $\Omega(1)$ .
  - Proof?
- 
- Corollary: Energy per gate is  $O(\log^2 \delta/s)$ , which is  $O(\log^2 s)$  if  $\delta$  is constant.
  - Proof?



# General Energy Upper Bound

**Theorem:** Given a circuit  $C$  with  $n$  gates that computes a relation  $f$  (with no failures), and a constant  $\delta$ , the optimal solution to MEC uses energy  $O(n \log n)$ .

**Proof idea:**

# General Energy Lower Bound

**Theorem:** Given  $\delta$  and a relation  $f$  with sensitivity  $s$ , the optimal solution to MEC requires energy  $\Omega(s \log(s/\delta))$ .

- The **sensitivity of on an input** is the number of bits of that, if flipped, change the output of .
- The **sensitivity of** is the maximum sensitivity of over all inputs.

**Proof idea:**

# Roadmap

- General bounds
- Approximation for Minimum Circuit Energy (MCE)
- Minimum Energy Circuit (MEC) for random functions
- Energy savings from allowing heterogeneous supply voltages

# MCE Problem

- Theorem: For constant  $\delta$ , the traditional approach is an  $\theta(\log^2 s)$  approximation.
  - Proof:
  - Traditional approach sets gate error  $\epsilon = \text{circuit error bound } \delta / s$
  - So traditional approach  $E = s \log^2 1/(\delta/n)$
  - Optimal  $E \geq s \log^2 1/\delta$  since  $\epsilon \leq \delta$



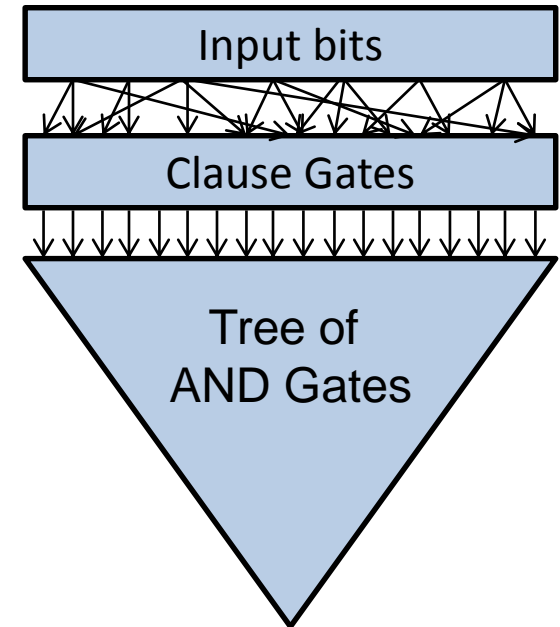
# MCE Problem

- Theorem: For constant  $\delta$ , it is NP-hard to obtain an  $o(\log^2 s)$  approximation.
  - Proof:
    - Reduction for gapped version of 3SAT
    - NP-hard Gapped 3SAT Problem:
      - Input: Formula  $F$
      - If  $F$  is satisfiable then the output has to be 1
      - If no assignment can not satisfy more than  $15/16$  of the clauses of  $F$  then the output has to be 0



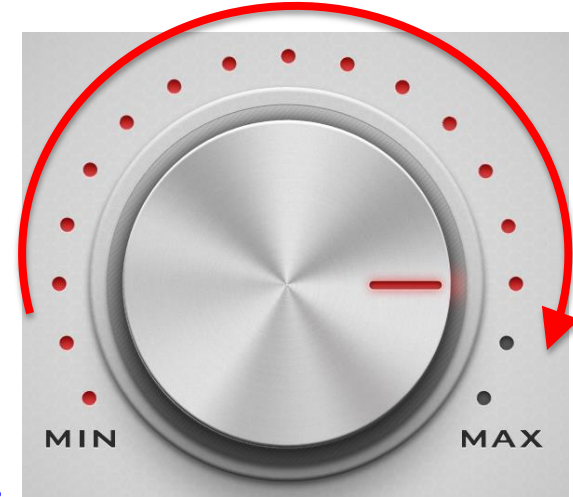
# NP-hardness Hardness via Reduction From 3SAT

- Consider the natural circuit corresponding to formula in conjunctive normal form
  - If no assignment can not not satisfy more than  $15/16$  of the clauses then AND gates can occasionally fault
    - OK to set  $\epsilon \approx \delta$
    - and hence the power can be a factor of  $\log^2 s$  less than traditional amount
  - If the formula is satisfiable,
    - then the AND gates basically can't fault on a satisfying input,
    - So we need  $\epsilon \leq \delta / s$
    - and hence the power is the traditional amount



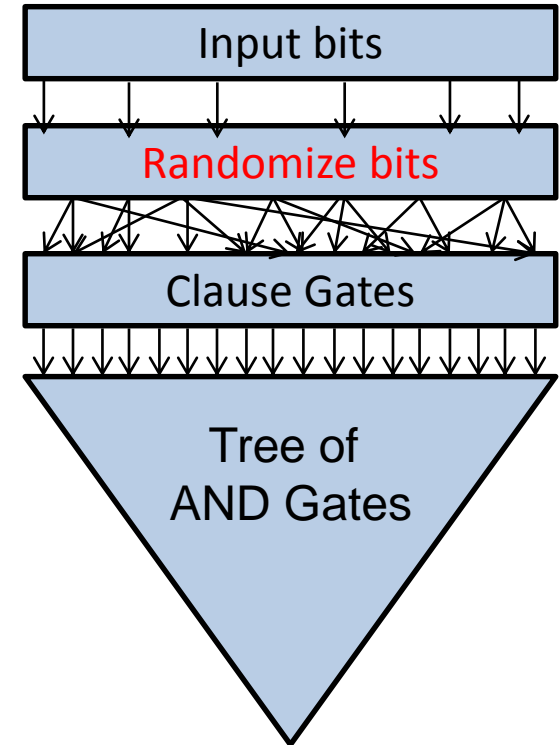
# MCE Problem

- Theorem: It is NP-hard to obtain an  $o(\log^2 n)$  approximation **even for a fixed input.**
  - Proof:
    - Reduction for gapped version of 3SAT
    - NP-hard Gapped 3SAT Problem:
      - Input: Formula  $F$
      - If  $F$  is satisfiable then the output has to be 1
      - If no assignment can not satisfy more than  $15/16$  of the clauses of  $F$  then the output has to be 0



# NP-hardness Hardness via Reduction From 3SAT

- Consider the natural circuit corresponding to formula in conjunctive normal form
  - How do you randomize a bit using faulty gates?



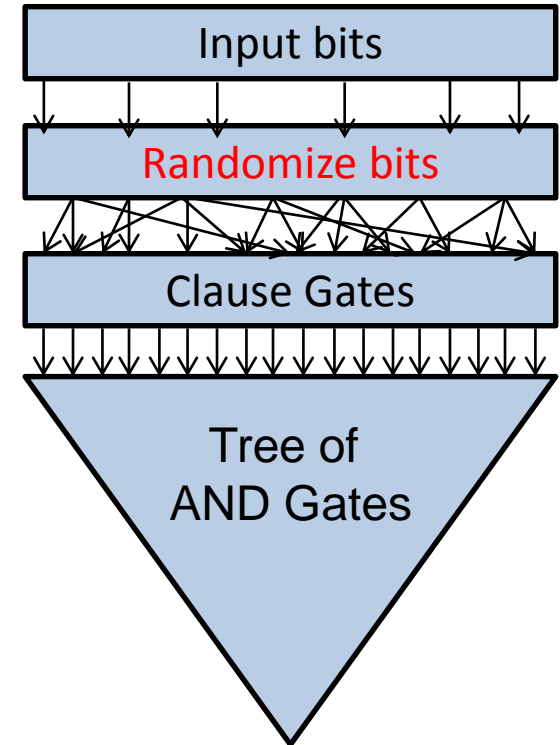
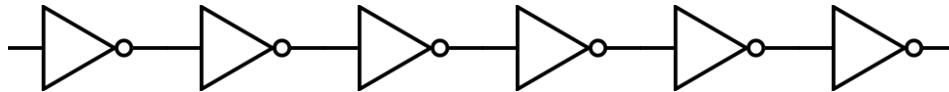


# NP-hardness Hardness via Reduction

## From 3SAT

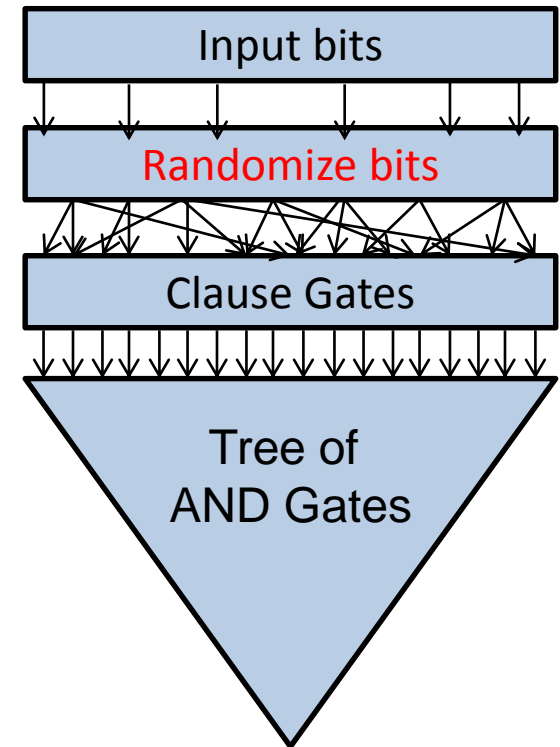
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– How do you randomize a bit using faulty gates?



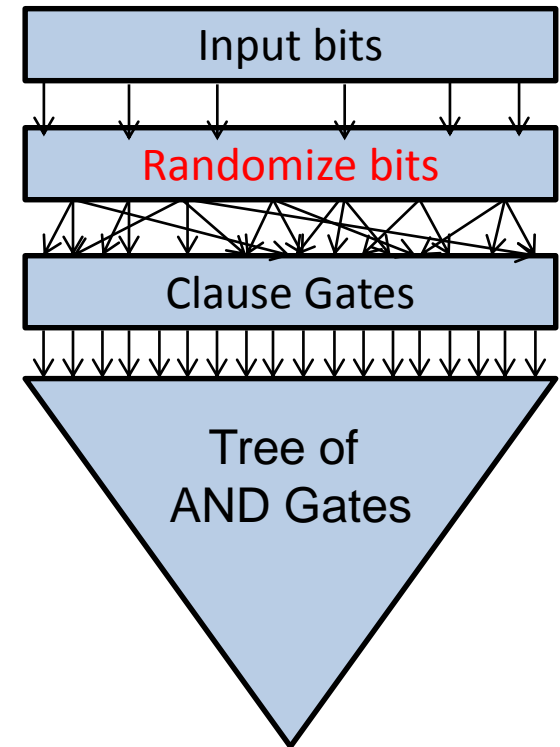
# NP-hardness Hardness via Reduction From 3SAT

- Consider the natural circuit corresponding to formula in conjunctive normal form
  - If at most 15/16th of the clauses are satisfiable
    - then many outputs of the clause gates are 0
    - OK if some of the AND gates fail
    - OK to set  $\epsilon \approx \delta$
    - and hence the power can be a factor of  $\log^2 n$  less than traditional amount



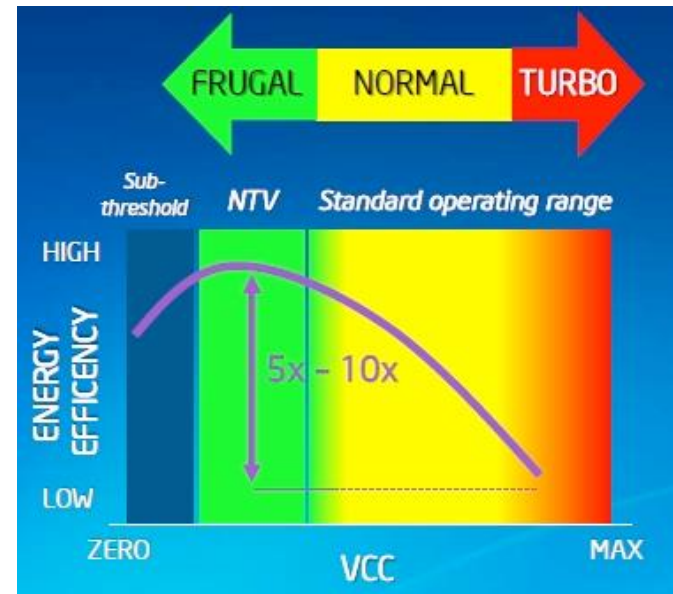
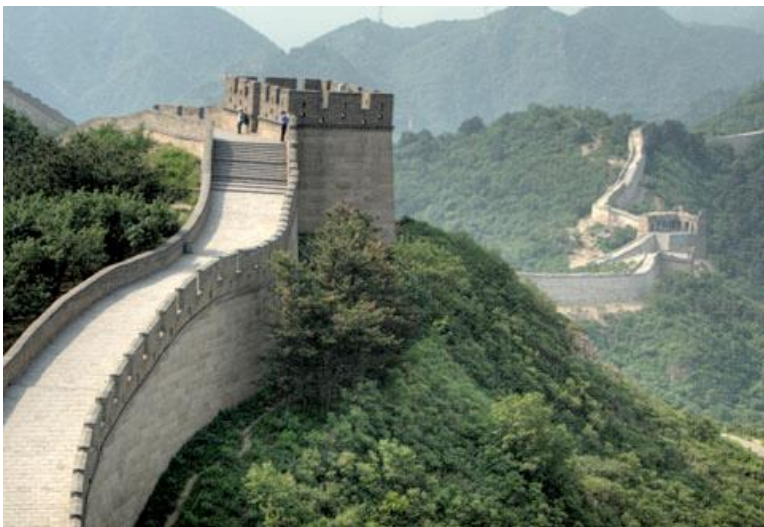
# NP-hardness Hardness via Reduction From 3SAT

- Consider the natural circuit corresponding to formula in conjunctive normal form
  - If the formula is satisfiable,
    - then the AND gates basically can't fault on the satisfying assignment,
    - So we need  $\epsilon \leq \delta / s$
    - and hence the power is the traditional amount



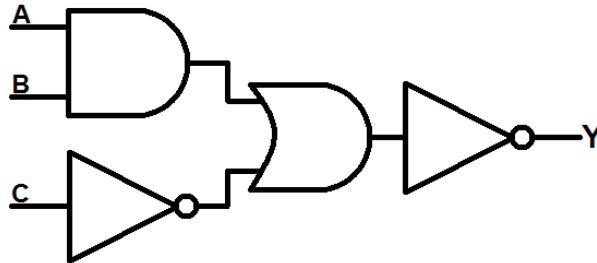
# Take Away Point: Beating the Traditional Approach is NP-hard

- Therefore, there is a complexity theoretic barrier to systematically achieving energy savings with near-threshold circuits.



# Positive Result MCE

- Optimal supply voltage can be computed if the circuit is a tree (out-degree of all gates is 1).
  - Suggests tractability for nearly treelike circuits



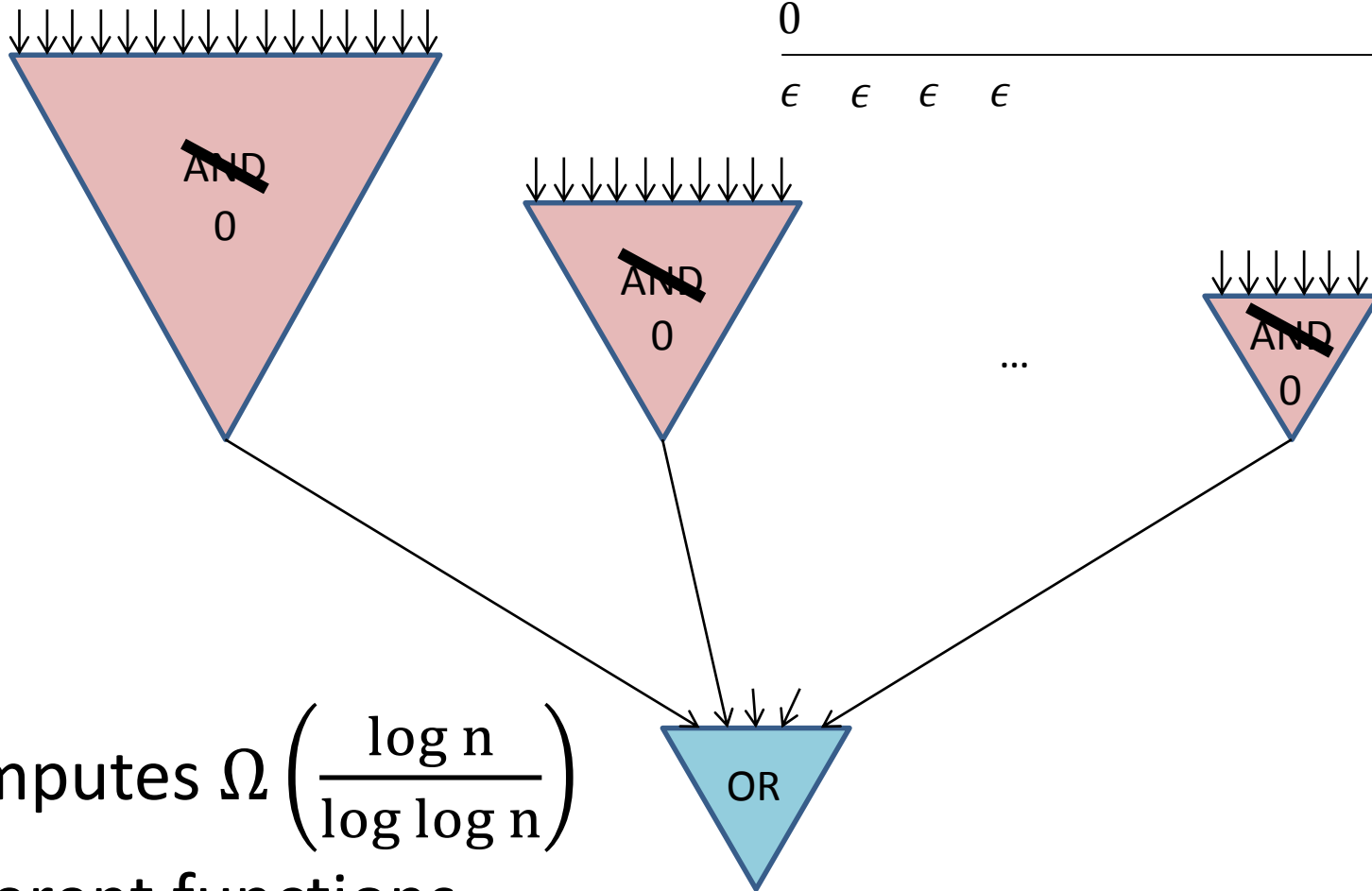
# Roadmap

- General bounds
- Approximation for Minimum Circuit Energy (MCE)
- Minimum Energy Circuit (MEC) for random functions
- Energy savings from allowing heterogeneous supply voltages

- Theorem [Shannon 1949]: Almost all Boolean functions on  $n$  bits require exponentially sized circuits:
- Proof:
  - There are  $2^{2^n}$  Boolean functions on  $n$  bits
  - There are only  $2^j$  circuits described by  $j$  bits
    - Thus at most  $2^{k \log k}$  circuits of  $k$  gates
  - Thus in order for  $2^{k \log k} > 2^{2^n} / 2$  then  $k$  needs to be at least  $2^n/n$
- Theorem: Almost all Boolean functions on  $n$  bits require exponential energy circuits
- Proof: Why won't the same proof work as we know you need constant energy per gate?

# Why Shannon's Proof Does Not Extend: Homogeneous Case

$\frac{1}{2}$





- Theorem: A circuit  $C$  with  $n$  inputs and  $s$  gates can compute at most  $s \cdot 2^n$  different functions.
  - Proof: Sufficient to show that on each input  $I$  (of the  $2^n$  inputs),  $C$  can only change its output  $s$  times.
  - Let  $p_I(\epsilon)$  be the probability that  $C$  outputs a 1 on input  $I$  when the gate error is  $\epsilon$
  - In order for the output to change  $p_I(\epsilon)$  has to transition from  $<\delta$  to  $>(1-\delta)$ , or visa versa.

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- Let  $p_I(\epsilon)$  be the probability that  $C$  outputs a 1 on input  $I$  when the gate error is  $\epsilon$
- In order for the output to change  $p_I(\epsilon)$  has to transition from  $<\delta$  to  $>(1-\delta)$ , or visa versa.
- $p_I(\epsilon) = \sum_k \sum_{G(k, I)} \epsilon^k (1-\epsilon)^{s-k}$ 
  - $k$  in  $[0, s]$  is number of gate failures
  - $G(k, I)$  collections of  $k$  gates such that when exactly these gates fail, the  $C$  on  $I$  outputs 1
- How often can  $p_I(\epsilon)$  transition?

- Theorem: Almost all Boolean functions on  $n$  bits require exponential energy circuits
- Proof:
  - There are  $2^{2^n}$  Boolean functions on  $n$  bits
  - There are only  $2^j$  circuits described by  $j$  bits
    - Thus at most  $2^{k \log k}$  circuits of  $k$  gates
    - Thus there are at most  $k \cdot 2^n$  different functions that each circuit can compute
  - Thus in order for  $2^{k \log k} \cdot k \cdot 2^n > 2^{2^n} / 2$  then  $k$  needs to be at least  $2^n/n$

# Roadmap

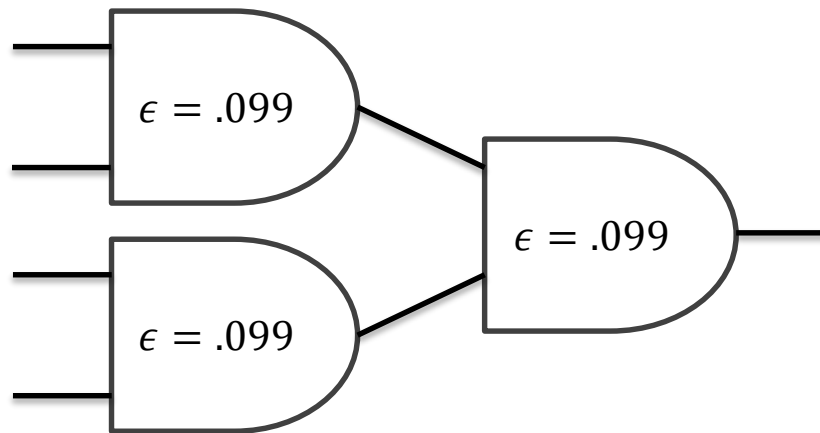
- General bounds
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# Homogeneous vs. Heterogeneous Supply Voltages

- Homogeneous supply voltages: the error probability  $\varepsilon_g$  is the same for each gate  $g$
- Heterogeneous supply voltages: each gate  $g$  may have a different error probability  $\varepsilon_g$
- Essentially all results so far would still hold if heterogeneous voltages were allowed, although sometimes the proof is harder.

# MCE Problem: Homogeneous Supply Voltages

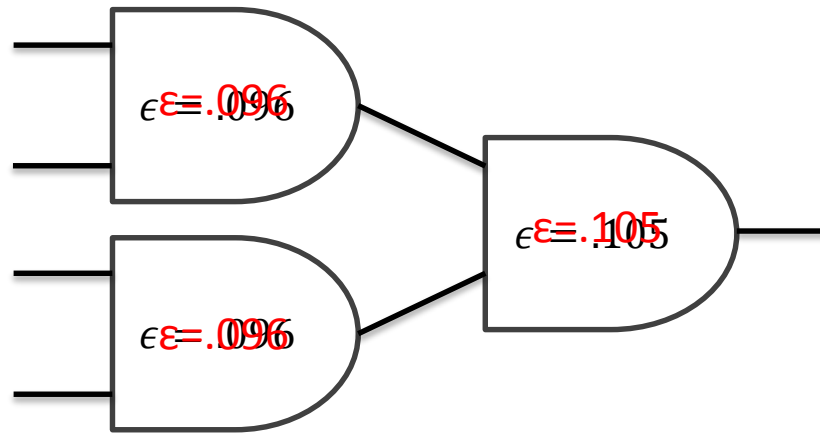
**Input:** Following circuit and  $\delta = .75$



- **Output:**
  - $\epsilon \approx .099$
  - Energy =  $3 \log^2 (1/.099) \approx 33.39$

# MCE Problem: Heterogeneous Supply Voltages

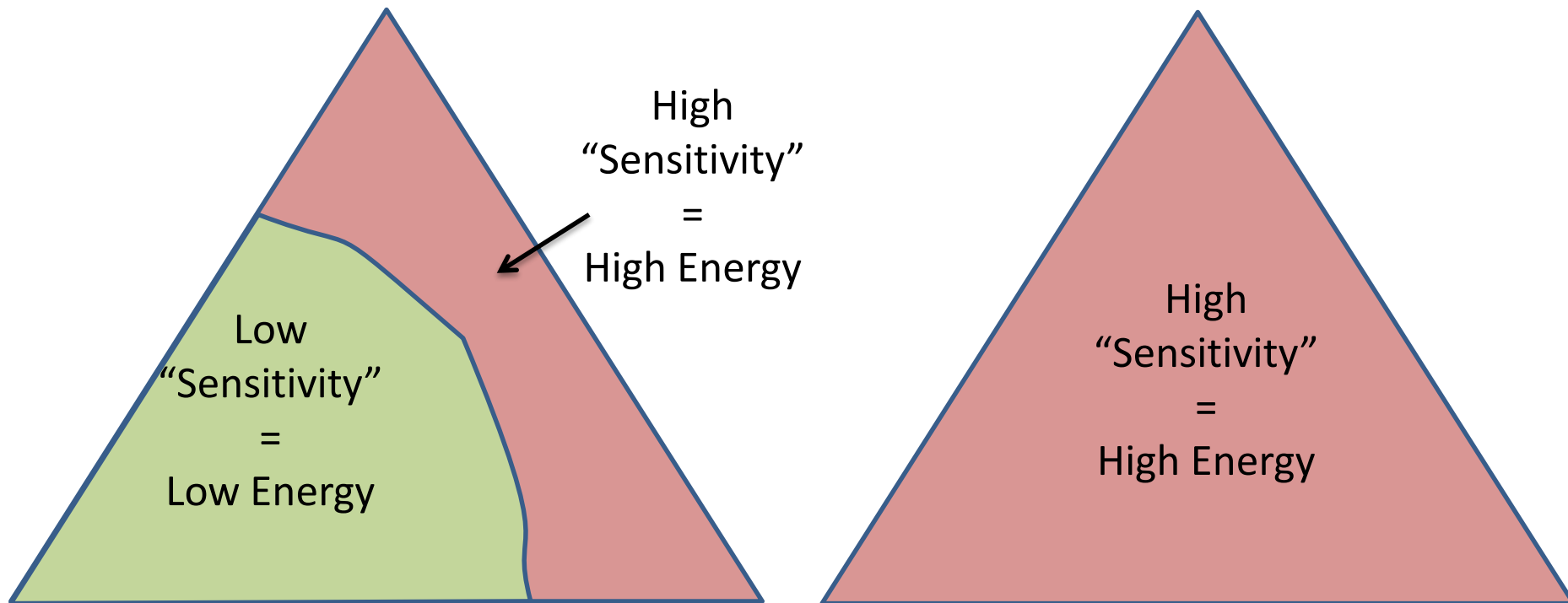
**Input:** Following circuit and  $\delta = .75$



**Output:**

- $\epsilon$ 's as shown above
- Energy =  $2 \log^2 (1/.096) + \log^2 (1/.105) \approx 33.39$
- Better by .1 % compared to optimal homogeneous

- Can you think of a circuit where heterogeneity would help save significant energy, and a circuit where it wouldn't?



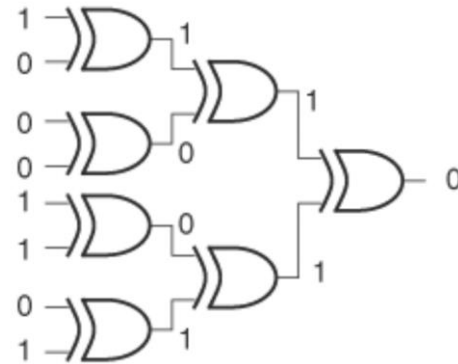


# A Case Where Heterogeneity Does Not Help

**Theorem:** For constant  $\delta \in (0, \frac{1}{2})$ , the solutions to MEC and HMEC for parity are within a constant.

- Parity has sensitivity  $n$  so the lower bound says that  $\Omega(n \log n)$  energy is required.

- This circuit computes the parity function:

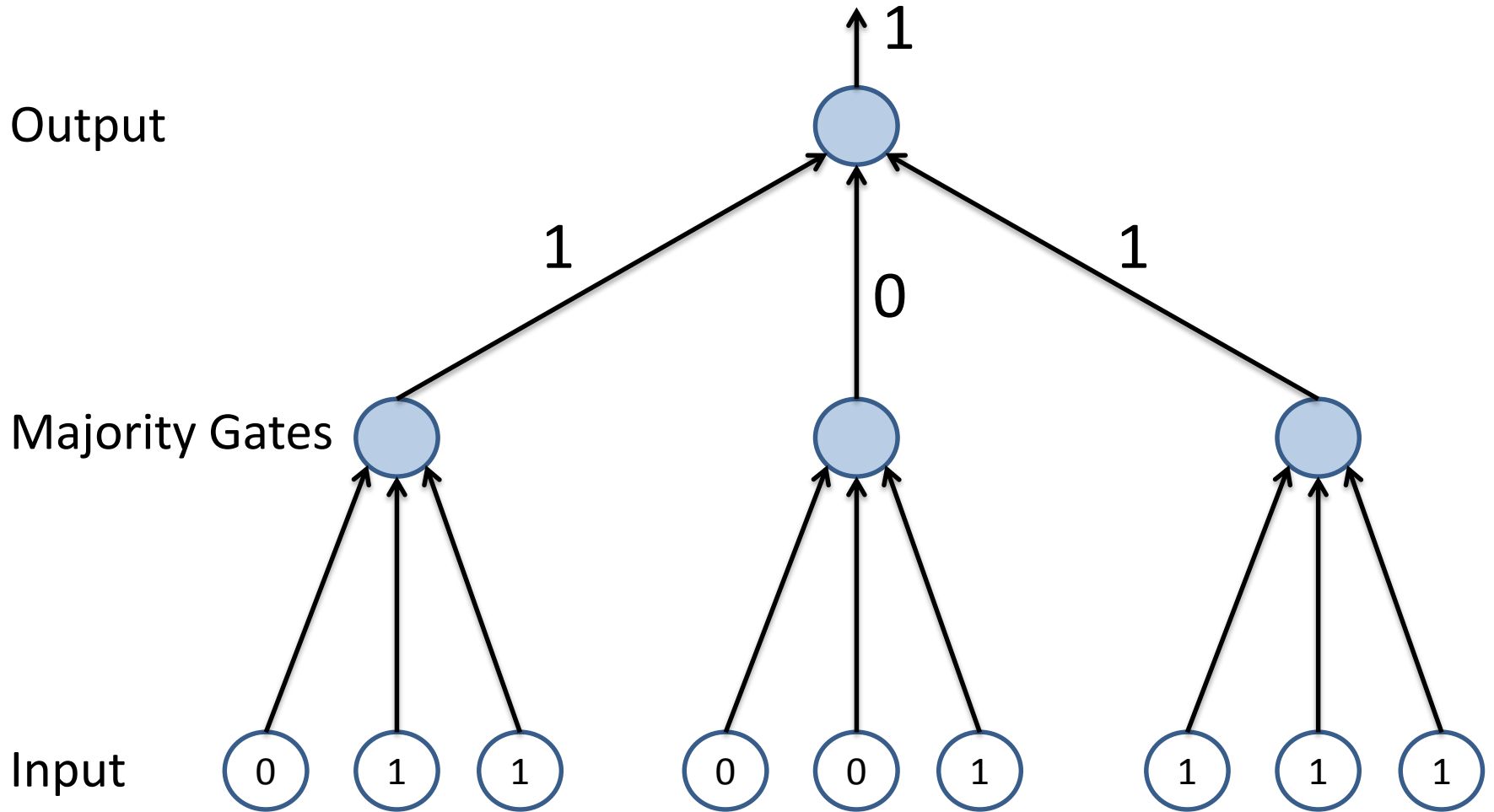


- It has size  $O(n)$  so the upper bound says  $O(n \log n)$  energy sufficient (and it uses homogeneous failure rates).

# A Case Where Heterogeneity Does Help

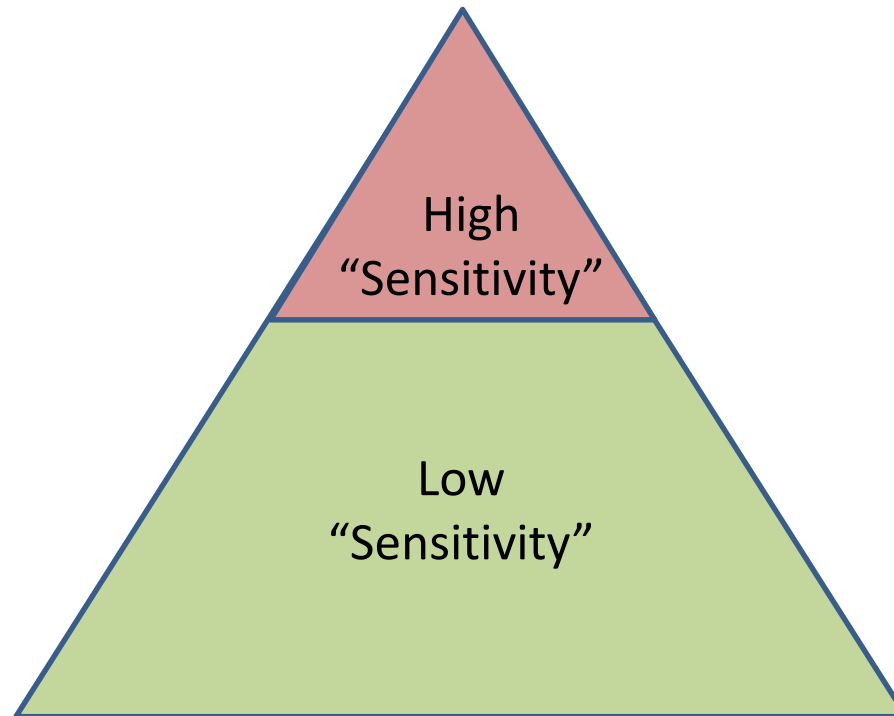
- Relation: The logarithmic supermajority relation,  $LSR(x) =$ 
  - 1 if  $> n - (\log_3 n)/2$  of the input bits are 1
  - 0 if  $> n - (\log_3 n)/2$  of the input bits are 0
  - Don't care otherwise
- Circuit Computing This Relation: Ternary tree of majority gates

# Supermajority Circuit



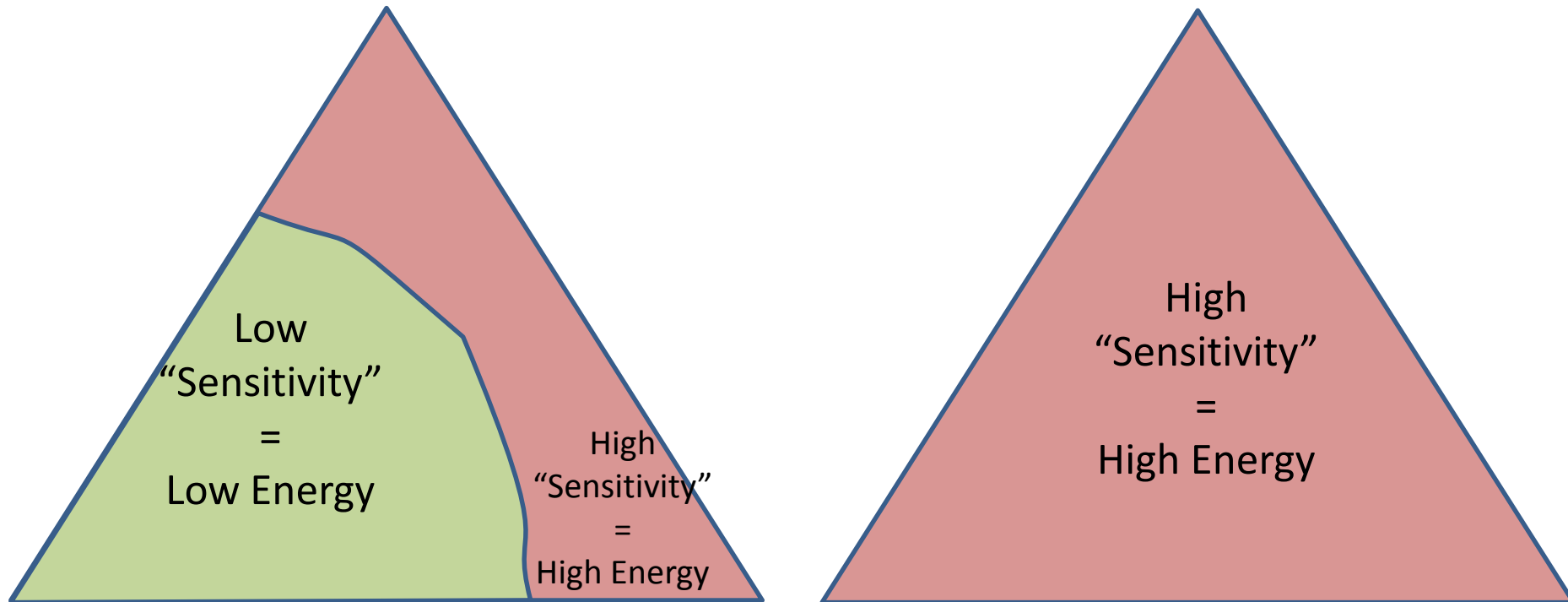
# Supermajority Circuit

- Root is more “sensitive” to failures.



# Big Question

- Are there functions/relations where there is an almost minimum energy circuit that is homogeneous?
- Are there functions/relations where there is no almost minimum energy circuit that is homogeneous?



# Energy Savings From Heterogeneity

	$\delta = \text{constant}$	$\delta = 1/\text{poly}$
Functions	$\Theta(1)$ for some $O(\log^2 n)$ for all	<ul style="list-style-type: none"><li>• <math>\Theta(\log n)</math> for all functions with linear sized circuits</li></ul>
Injective Relations	$\Theta(1)$ for some $O(\log^2 n)$ for all	<ul style="list-style-type: none"><li>• <math>\Omega(\log^2 n)</math> for some</li><li>• <math>O(\log^2 n)</math> for relations with linear sized circuits</li></ul>

Energy savings for function/relation  $F$  = ratio

Minimum energy used by a homogeneous circuit for  $F$

---

Minimum energy used by a heterogeneous circuit for  $F$

# Energy Savings From Heterogeneity

	$\delta = \text{constant}$	$\delta = 1/\text{poly}$
Functions	$\Theta(1)$ for some $O(\log^2 n)$ for all	<ul style="list-style-type: none"><li>• <math>\Theta(\log n)</math> for all functions with linear sized circuits</li></ul>
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Proofs?

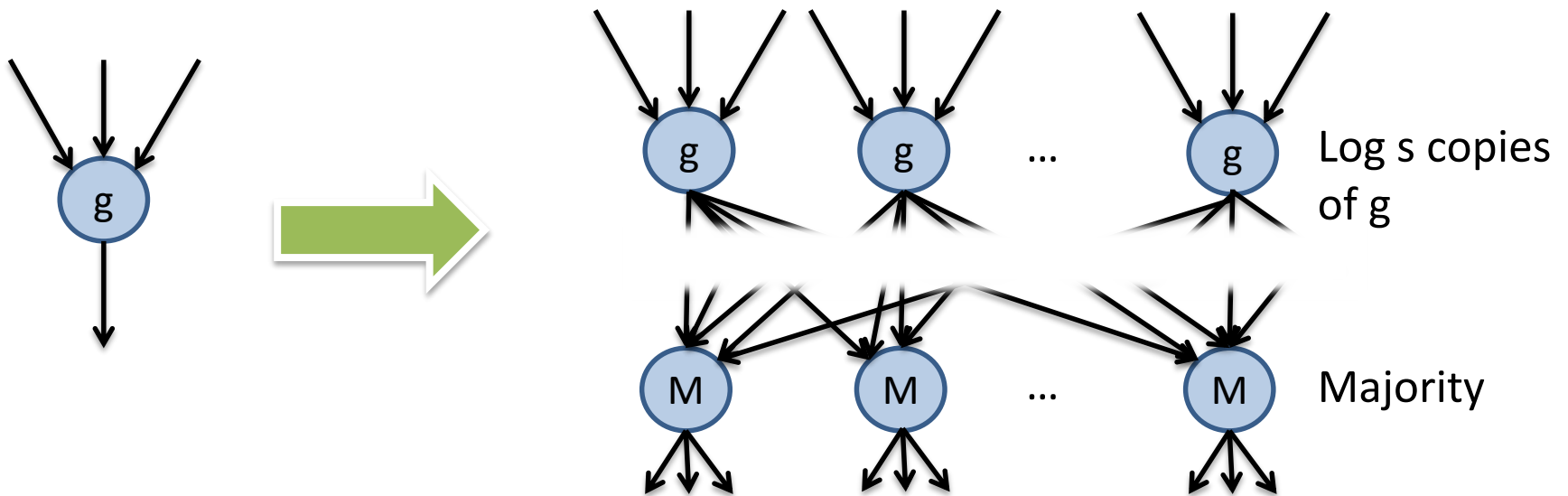
# $\Omega(\log n)$ Energy Savings For Functions when $\delta = 1/n$

- **Theorem:** For  $\delta = 1/n$ , and for every function  $F$  on  $n$  input bits with a  $s$  gate circuit:
  - Every circuit with homogeneous supply voltages that computes  $F$  uses  $\Omega(n \log^2 n)$  energy.
  - There is a circuit with heterogeneous supply voltages that computes  $F$  using  $O(s \log s)$  energy
- Note:  $\Omega(\log n)$  energy savings if  $s = \Theta(n)$
- Proof: First statement is trivial



# Proof: Heterogeneous Circuit Using $O(s \log s)$ Energy

- Each of  $s$  gates  $g$  in error-free circuit is replaced by a gadget:

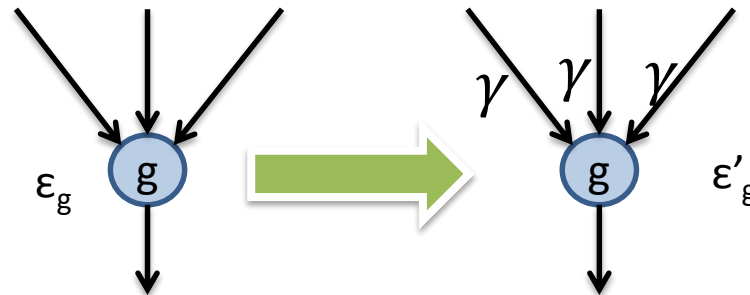


- $\epsilon = \text{constant}$  for these gadgets, so energy  $\Theta(s \log s)$
- If most of the inputs into the gadget are correct, then most of the outputs are correct
- Final majority circuit of size  $\log n$  with  $\epsilon = 1/s^2$ , so energy  $\Theta(\log^3 s)$

# $O(\log n)$ Limit on Energy Savings for Functions when $\delta=1/n$

**Theorem:** For any function  $F$  whose output depends on all  $n$  inputs, every heterogeneous circuit that computes  $F$  requires  $\Omega(n \log n)$  energy

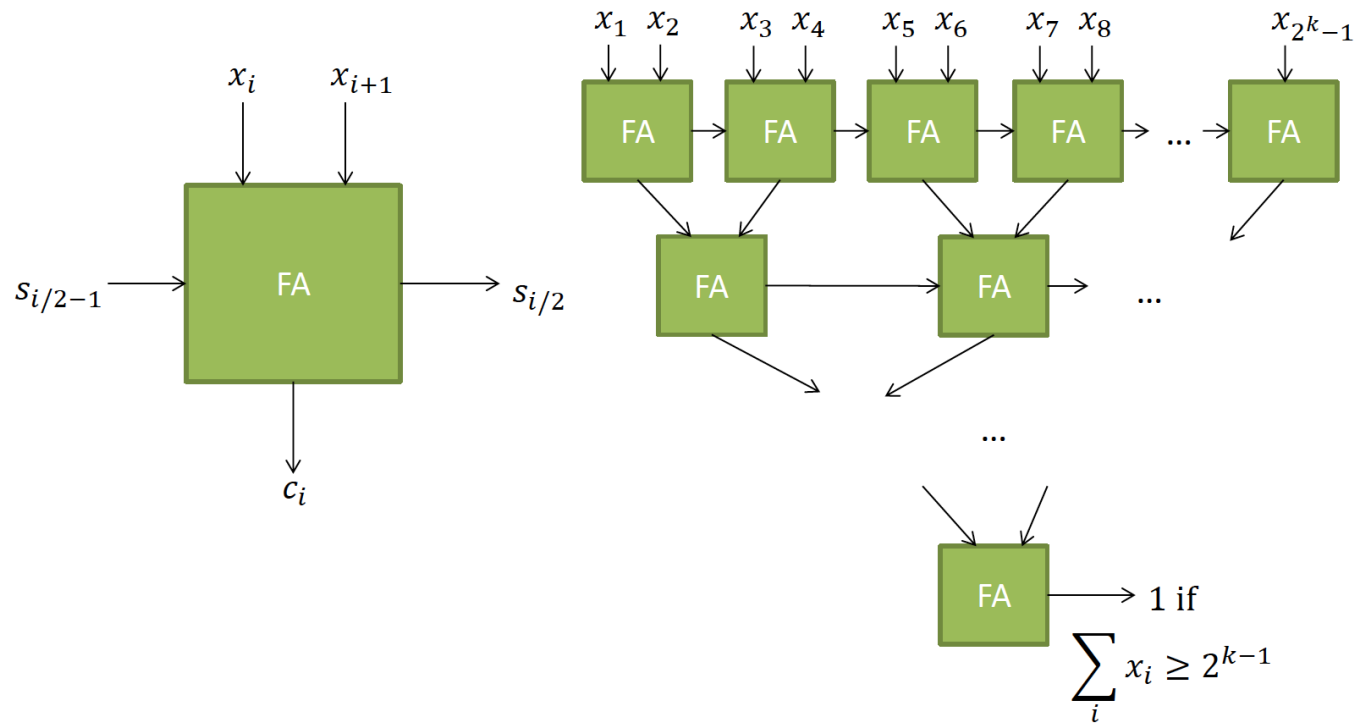
**Proof Idea:**  $\log n$  copies with constant error per copy is the most energy efficient way to get aggregate error  $1/n$



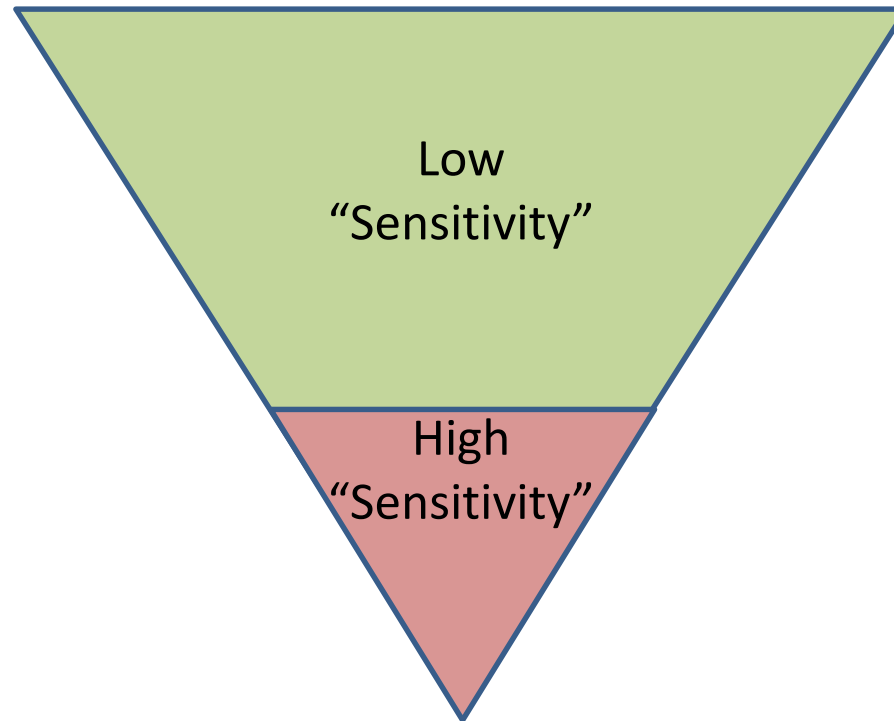
# $\Omega(\log^2 n)$ Energy Savings For Supermajority Relation when $\delta = 1/n$

- **Supermajority Relation**: Only needs to be correct if  $\frac{3}{4}$  majority.
- **Theorem**: For  $\delta = 1/n$ ,
  - Every circuit with homogeneous supply voltages that computes the supermajority relation and that uses  $\Omega(n \log^2 n)$  energy.
  - There is a circuit with heterogeneous supply voltages that computes the supermajority relation and uses  $O(n)$  energy
- Proof: **First statement is trivial**

# Proof: Low Energy Heterogeneous Circuit

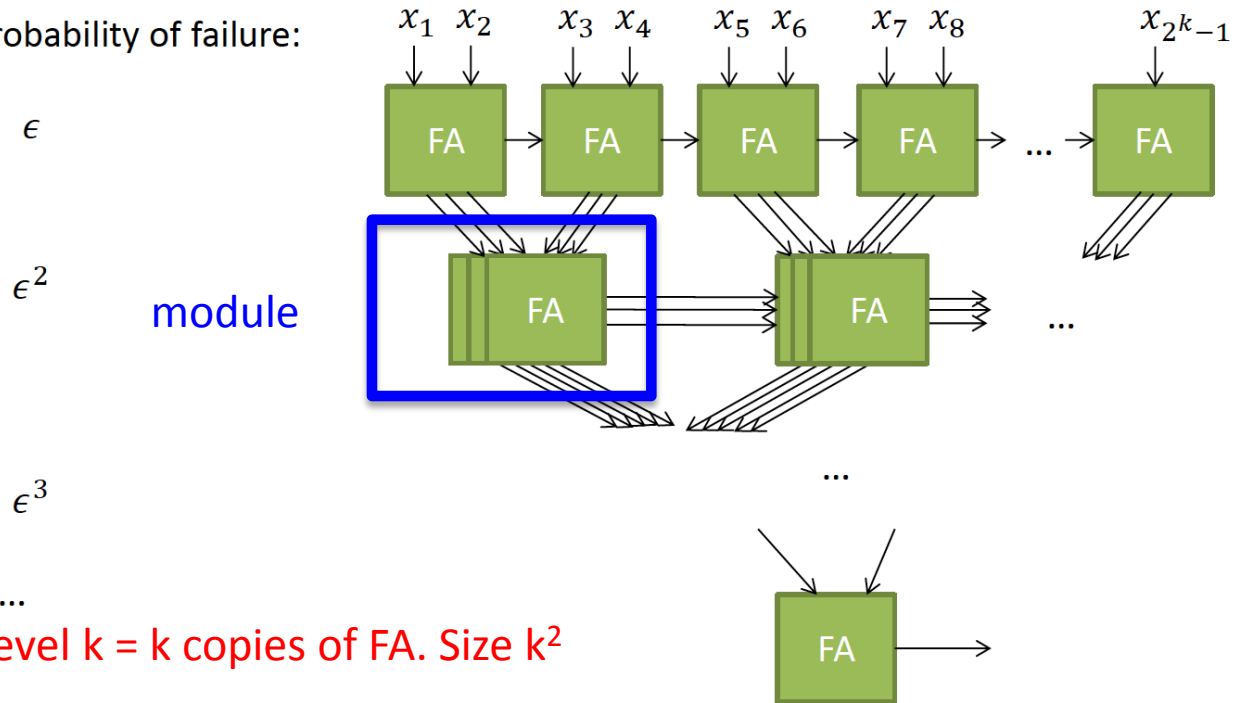


# Intuition



# Proof: Low Energy Heterogeneous Circuit

Approximate probability of failure:



- Module on level  $k = k$  copies of FA. Size  $k^2$
- $\epsilon$  is small constant
- Number of gates = energy =  $\sum_{k=1 \dots \log n} (n/2^k) (k^2) \log 1/\epsilon^k$
- Final level, high energy

# Future

- Establish a more complete understanding of the power of heterogeneous supply voltages
- Find good algorithmic problems involving tradeoffs between energy and fault-tolerance in other settings.

# Covered Papers:

## Thanks to my collaborators

- A. Antoniadis, N. Barcelo, M. Nugent, K. Pruhs, and M. Squizzato. *Energy-efficient circuit design*. 5<sup>th</sup> conference on Innovations in Theoretical Computer Science (ITCS 2014).
- A. Antoniadis, N. Barcelo, M. Nugent, K. Pruhs, and M. Squizzato. *Complexity-theoretic obstacles to achieving energy savings with Near-Threshold Computing*. 5<sup>th</sup> International Green Computing Conference (IGCC 2014).
- N. Barcelo, M. Nugent, K. Pruhs, and M. Squizzato. *Almost all functions require exponential-energy circuits*. 40<sup>th</sup> International Symposium on Mathematical Foundations of Computer Science (MFCS 2015).
- N. Barcelo, M. Nugent, K. Pruhs, and M. Squizzato. *The power of heterogeneity in Near-Threshold Computing*. 6<sup>th</sup> International Green and Sustainable Computing Conference (IGSC 2015).



# Thanks for listening!

